

Search Notes**Application/Control No.**

10/761,080

Examiner

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Applicant(s)/Patent under Reexamination

BEAUCHAMP, PHILLIP J.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
216	84	9/26/2006	BT
216	85	9/26/2006	BT
216	92	9/26/2006	BT
216	97	9/26/2006	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	9/26/2006	BT

INTERFERENCE SEARCHED

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216	84	9/26/2006	BT
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216/97		9/26/2006	BT